N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, e}	Q _g (Typ.)			
20	0.0019 at V _{GS} = 4.5 V	147	61 nC			
20	0.0023 at V _{GS} = 2.5 V	110	OTTIC			

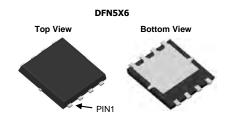
FEATURES

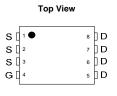
- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested

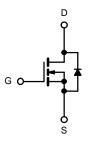


APPLICATIONS

- OR-ing
- Server







N-Channel MOSFET

	$T_A = 25 ^{\circ}C$, unle			1	
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	20	V		
Gate-Source Voltage	V _{GS}	± 12			
	T _C = 25 °C		147 ^{a, e}		
Continuous Drain Current (T, = 175 °C)	T _C = 70 °C	I _D	110 ^e		
Continuous Brain Current (1j = 175 °C)	T _A = 25 °C	'U	52 ^{b, c}	A	
	T _A = 70 °C		47.8 ^{b, c}		
Pulsed Drain Current	I _{DM}	450			
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	65		
Single Pulse Avalanche Energy	L = 0.1 IIIA	E _{AS}	120	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	87 ^{a, e}	Α	
Continuous Source-Diam Diode Current	T _A = 25 °C	'S	3.02 ^{b, c}		
	T _C = 25 °C		247 ^a		
Maximum Pawar Dissipation	T _C = 70 °C	P _D	169	- w	
Maximum Power Dissipation	T _A = 25 °C	' D	3.72 ^{b, c}		
	T _A = 70 °C		2.61 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	12	19	°C/W		
Maximum Junction-to-Case	Steady State	R _{thJC}	1.1	1.8	10/00		

Notes:

- a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 90 °C/W.
- e. Calculated based on maximum junction temperature. Package limitation current is 90 A.



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Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	- J I _D = 250 μA		35		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	ι _D = 230 μΑ		- 7.5		mv/-C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.8		2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V			1	μA
		$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	90			Α
	В	$V_{GS} = 4.5 \text{ V}, I_D = 32 \text{ A}$		0.0019	0.0021	Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 29 \text{ A}$		0.0023	0.0025	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 32 A		100		S
Dynamic ^b			•			
Input Capacitance	C _{iss}			4933		pF
Output Capacitance	C _{oss}	V_{DS} = 12.5 V, V_{GS} = 0 V, f = 1 MHz		1991		
Reverse Transfer Capacitance	C _{rss}			983		
Total Cata Chargo	Qg	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 32 \text{ A}$		61		nC
Total Gate Charge				80.3		
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 29 \text{ A}$		33		
Gate-Drain Charge	Q_{gd}			31		
Gate Resistance	R_g	f = 1 MHz		1.2		Ω
Turn-On Delay Time	t _{d(on)}			19	30	
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.555 Ω		12	20	ns
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 27 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		75	111	
Fall Time	t _f			11	15	
Turn-On Delay Time	t _{d(on)}			56	85	
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.625 Ω		180	268	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 24 A, V_{GEN} = 4.5 V, R_g = 1 Ω		58	83	
Fall Time	t _f			14	21	
Drain-Source Body Diode Characteristic	S					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			147	Δ
Pulse Diode Forward Current ^a	I _{SM}				450	Α
Body Diode Voltage	V _{SD}	I _S = 22 A		0.7	1.0	V
Body Diode Reverse Recovery Time	t _{rr}			52	75	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _{.I} = 25 °C		70.2	102	nC
Reverse Recovery Fall Time	ta	$_{1F} - 20 A$, $_{1J} = 25 C$		26		ns
Reverse Recovery Rise Time	t _b			24		

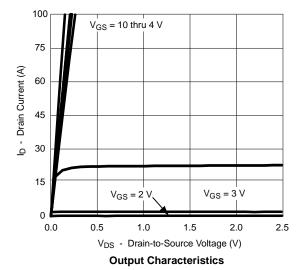
Notes:

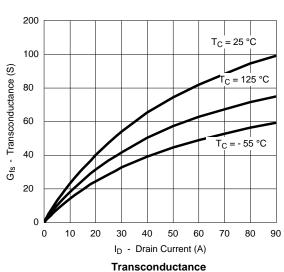
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

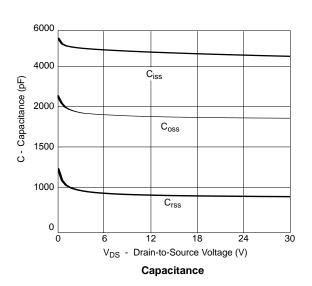
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

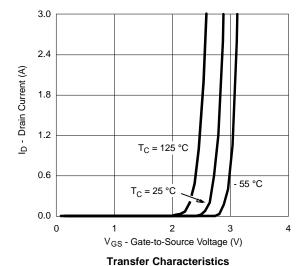
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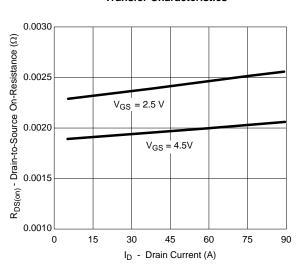
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

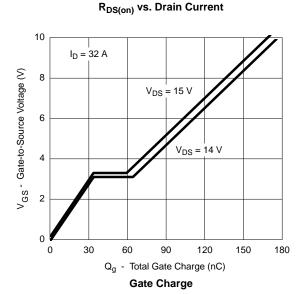






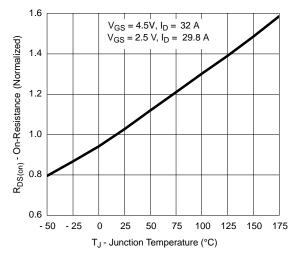




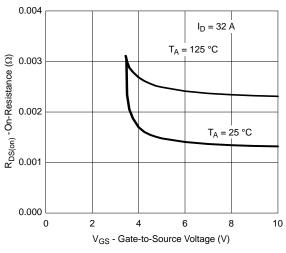




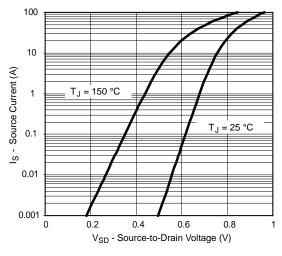
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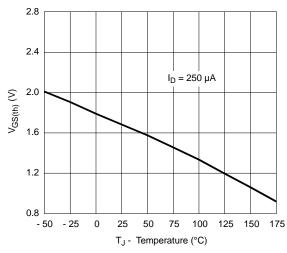
On-Resistance vs. Junction Temperature



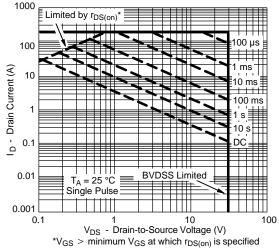
 $R_{DS(on)}$ vs. V_{GS} vs. Temperature



Forward Diode Voltage vs. Temperature



Threshold Voltage

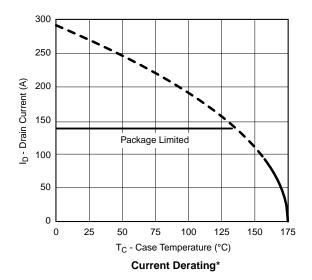


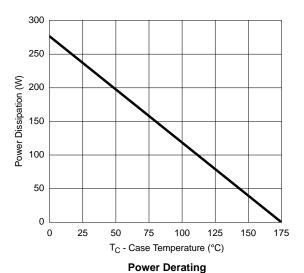
Safe Operating Area, Junction-to-Ambient



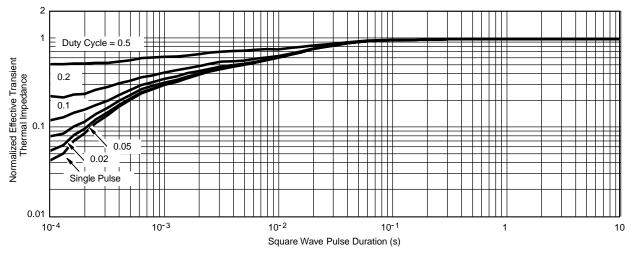








* The power dissipation P_D is based on $T_{J(max)}$ = 175 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

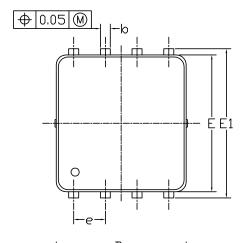


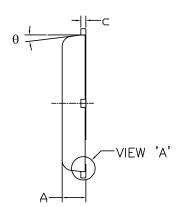
Normalized Thermal Transient Impedance, Junction-to-Case

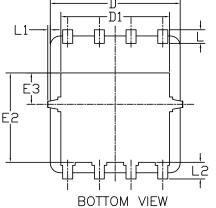


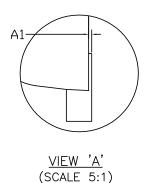
DFN5x6_8L_EP1_P PACKAGE OUTLIN



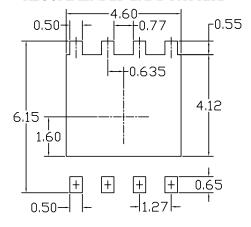








RECOMMENDED LAND PATTERN



SYMBOLS	DIMENS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
3 I MBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.85	0. 95	1.00	0.033	0.037	0.039	
Al	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
С	0. 15	0. 20	0. 25	0.006	0.008	0.010	
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209	
D1	4. 25	4. 35	4. 45	0. 167	0.171	0. 175	
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222	
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242	
E2	3. 525	3. 625	3. 725	0. 139	0. 143	0. 147	
E3	1. 175	1. 275	1. 375	0.046	0.050	0.054	
e	1. 27 BSC			0.050 BSC			
L	0.45	0. 55	0.65	0.018	0.022	0.026	
L1	0		0. 15	0		0.006	
L2	0.68 REF			0.027 REF			
θ	0°		10°	0°		10°	

NOTE

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SEMICONDUCTOR

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

UNIT: mm





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